						Docket Number (Optional) BUR92003014	Application Number 10 / 707,039					
	INFO	RMATI	ON DISCLOSURE	E CITATION		Applicant(s) Maynard et al.						
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Form PTO-A820 (also form PTO-1449)

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FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT				APPLICANT Seale, et al.					
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